Search Notes



Applicant(s)/Patent Under Reexamination

2618

10799900 WAIGHT ET AL.

Examiner Art Unit

SEARCHED

Pablo N Tran

Class	Subclass	Date	Examiner	
455	333, 323, 326, 313, 332, 286-290, 293	11/9/09	PT	
333	186, 175	11/9/09	PT	
330	175	11/30/09	PT	

SEARCH NOTES

52.ii.011.ii.0125		
Search Notes	Date	Examiner
East/West	11/9/09	PT

INTERFERENCE SEARCH

	INTERFERENCE SEARCH	INTERPERENCE SEARCH		
Class	Subclass	Date	Examiner	

/Pablo N Tran/ Primary Examiner.Art Unit 2618

U.S. Patent and Trademark Office Part of Paper No.: 20091108